

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SWANSON ET AL.	
		Examiner N. M. Minnifield	Art Unit 1645	Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,632,937	10-2003	Swanson et al.	536/23.7
	B	US-2003/0175708	09-2003	Swanson et al.	435/6
	C	US-2003/0054364	03-2003	Swanson et al.	435/6
	D	US-2002/0198365	12-2002	Swanson et al.	530/388.1
	E	US-2002/0160476	10-2002	Swanson et al.	435/183
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Fuerst et al, FEMS Microbiology Letters, 1998, 166:29-34
	V	Jurgens et al, FEMS Microbiology Ecology, June 1999, 29/2:205-213 Abstract only
	W	Wuchter et al, FEMS Microbiology, Letters, 2003, 219:203-207
	X	DeLong et al, Biological Bulletin, 1999, 196/3:363-366

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SWANSON ET AL.	
		Examiner N. M. Minnifield	Art Unit 1645	Page 2 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Pearson et al, Applied and Environmental Microbiology, Sept. 2004, 70(9):5229-5237
	V	de la Torre et al, Abstracts of general ASM Mtg, 2002, 102:320 Abstract only
	W	Sandler et al, J. Bacteriology, Feb. 1999, 181(3):907-915
	X	Lee et al, Biomolecular Engineering, 2003, 20:299-304

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SWANSON ET AL.	
		Examiner	Art Unit	Page 3 of 3
		N. M. Minnifield	1645	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-				
B	US-				
C	US-				
D	US-				
E	US-				
F	US-				
G	US-				
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N						
O						
P						
Q						
R						
S						
T						

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U		Houghten et al, Vaccine, 1986, pp. 21-25
V		
W		
X		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.